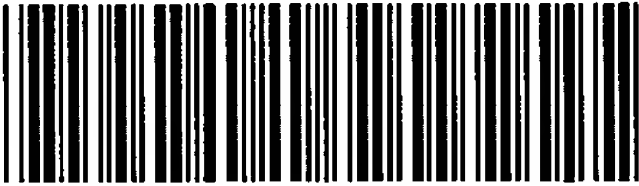


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/667,474	CHO ET AL.	
	Examiner	Art Unit	
	Leonardo Andújar	2826	

SEARCHED			
Class	Subclass	Date	Examiner
2357	673-676 690, 777	4/10/2005	LA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST Search	4/10/2005	LA